Application/Control No. Applicant(s)/Patent Under Reexamination 10/715,769 INAGAKI ET AL. Notice of References Cited Examiner Art Unit Page 1 of 1 J. Derek Rutten 2192 **U.S. PATENT DOCUMENTS Document Number** Date Name Classification Country Code-Number-Kind Code MM-YYYY * US-7,013,456 B1 03-2006 Van Dyke et al. Α 717/130 * В US-7,080,289 B2 07-2006 Swaine et al. 714/45 US-С US-D US-Ε US-F US-G US-Н US-US-J

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